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(54) **PICTURE ELEMENT STRUCTURE OF CURRENT PROGRAMMING METHOD TYPE ACTIVE MATRIX ORGANIC EMITTING DIODE DISPLAY AND DRIVING METHOD OF DATA LINE**

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(57) **ABSTRACT**

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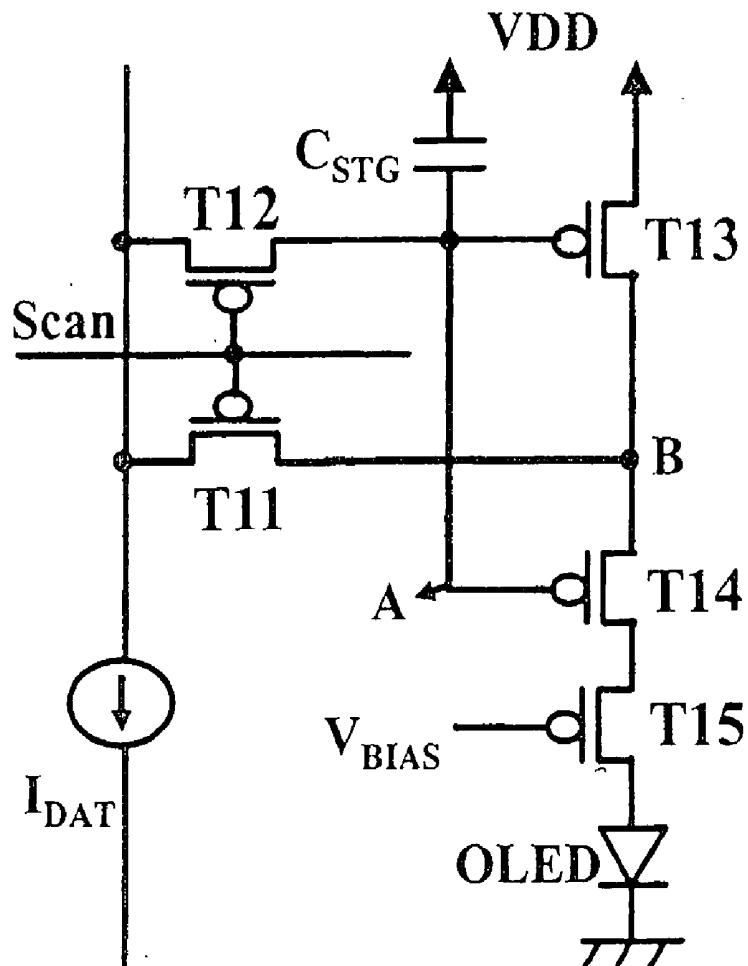
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The present invention provides a novel structure of picture elements in current programming-type semiconductor devices, and in particular, the structure of picture elements of an active matrix organic light emitting diode (OLED) display. The device makes a self-compensation for OLED current deviations due to the deterioration in threshold voltage and uneven electric characteristic in thin film transistors. The invention also provides a method for driving a data driver capable of compensating for the uneven electric characteristic of thin film transistors in the driver for driving picture elements in the current programming-type active matrix OLED display device.



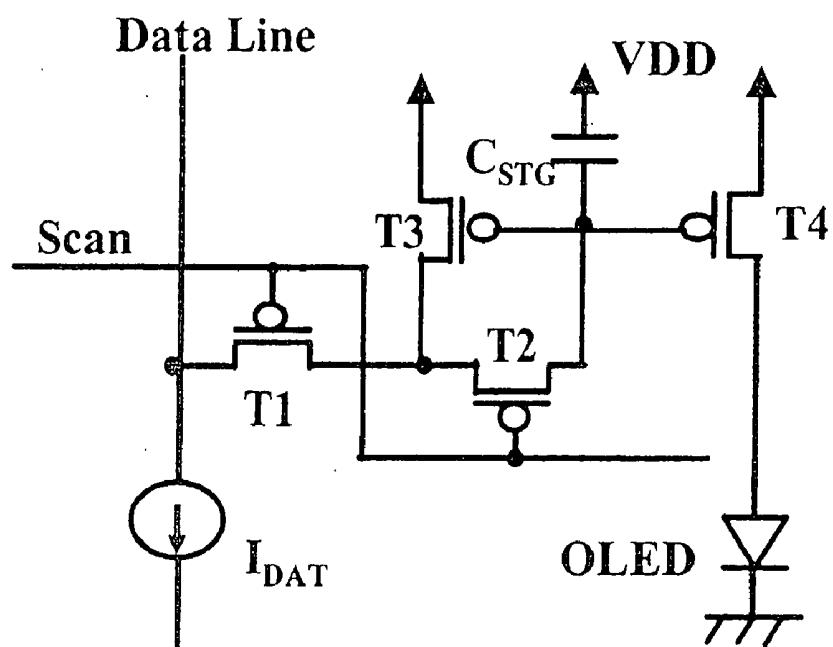


FIG.1

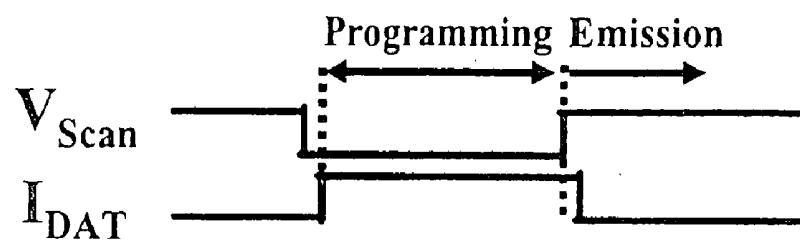


FIG.2

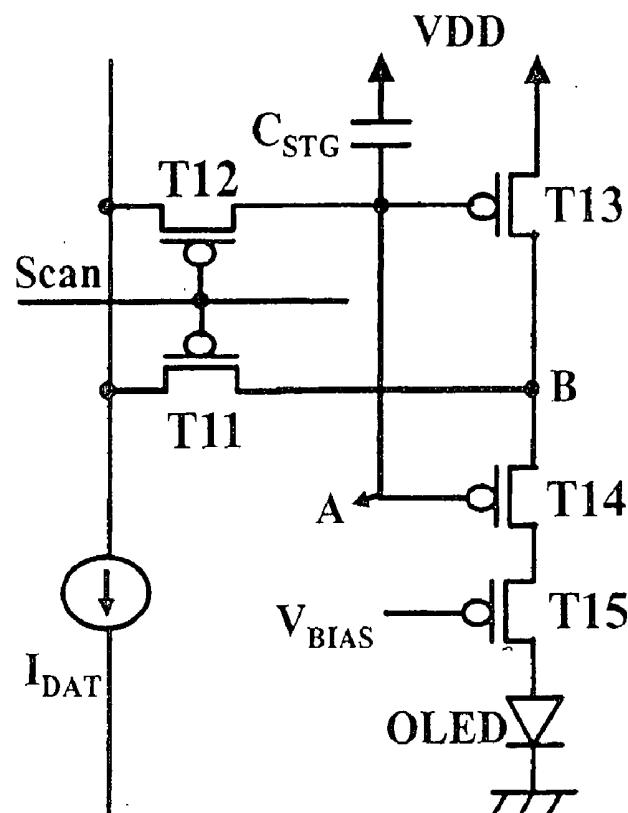


FIG.3

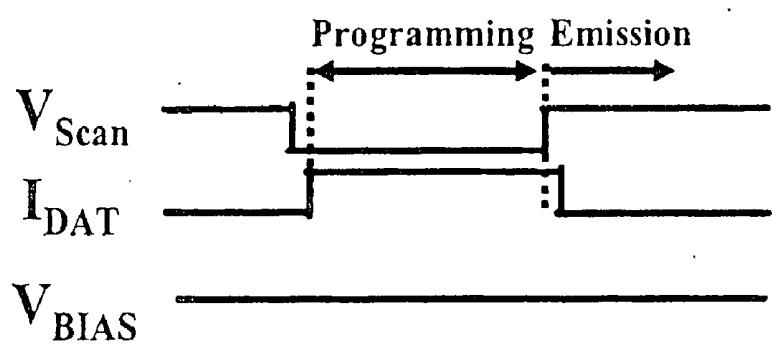


FIG.4

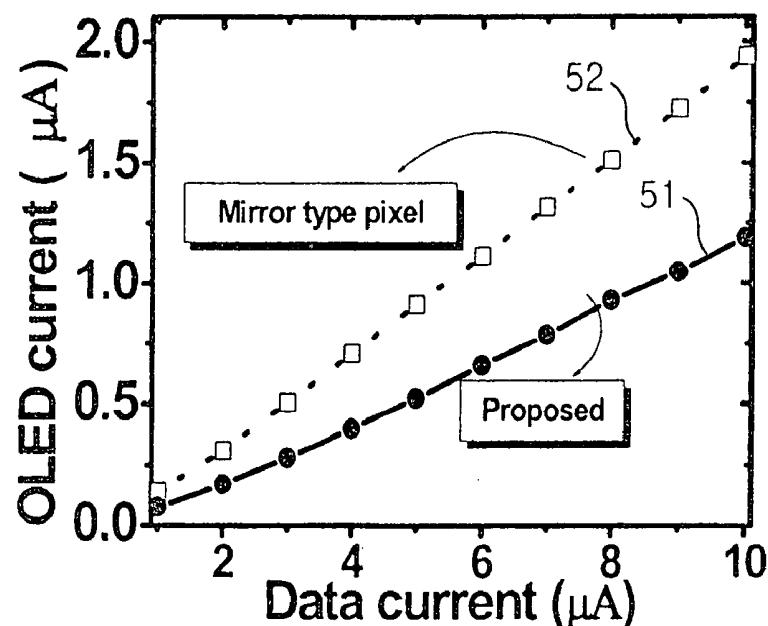


FIG.5

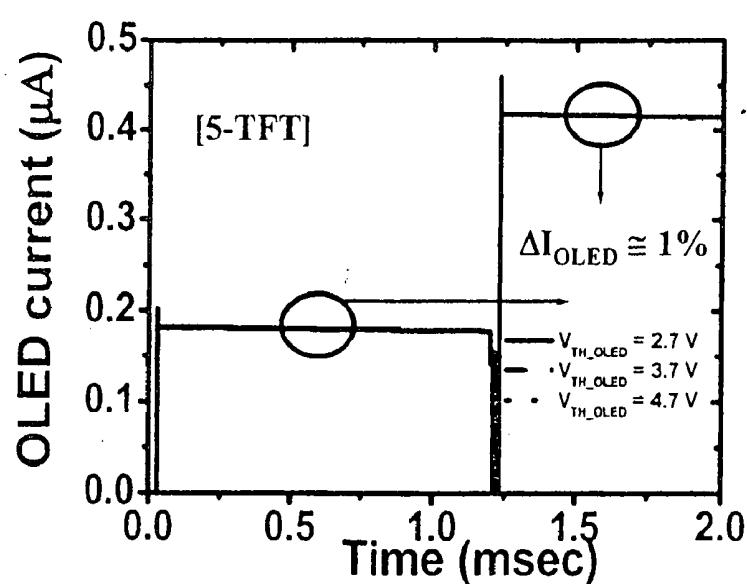


FIG.6A

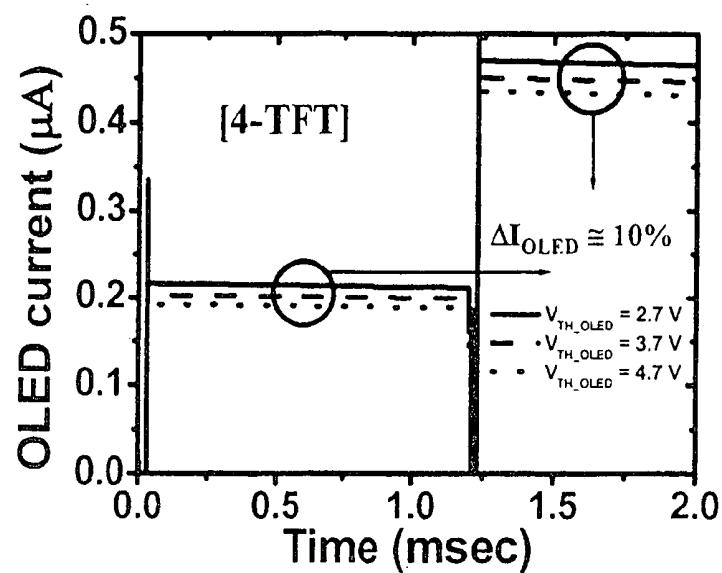


FIG.6B

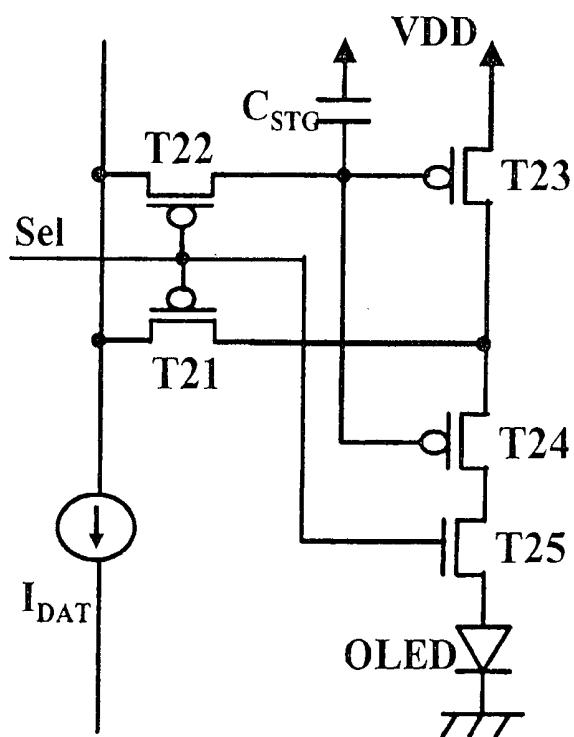


FIG.7

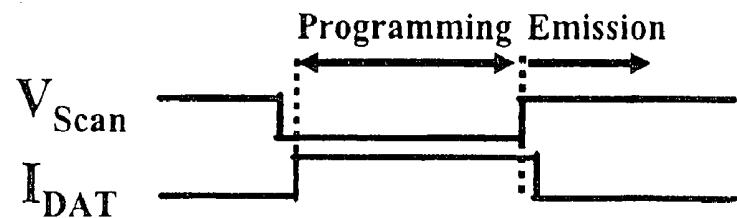


FIG.8

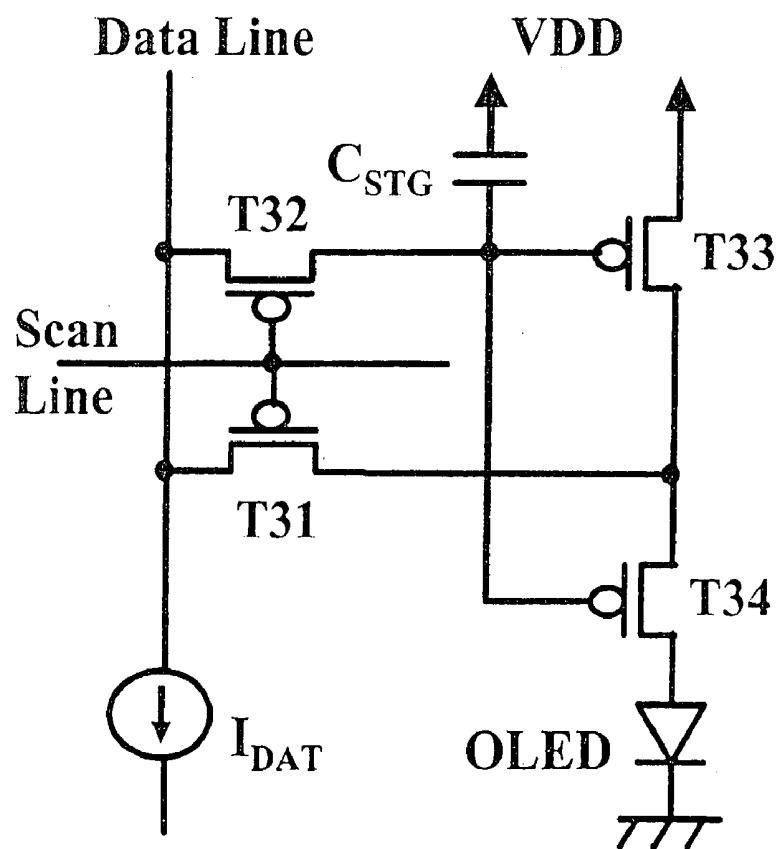


FIG.9

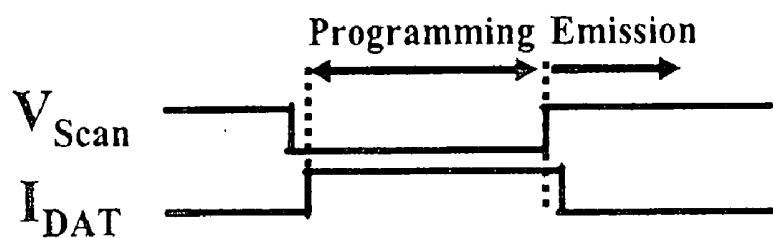


FIG.10

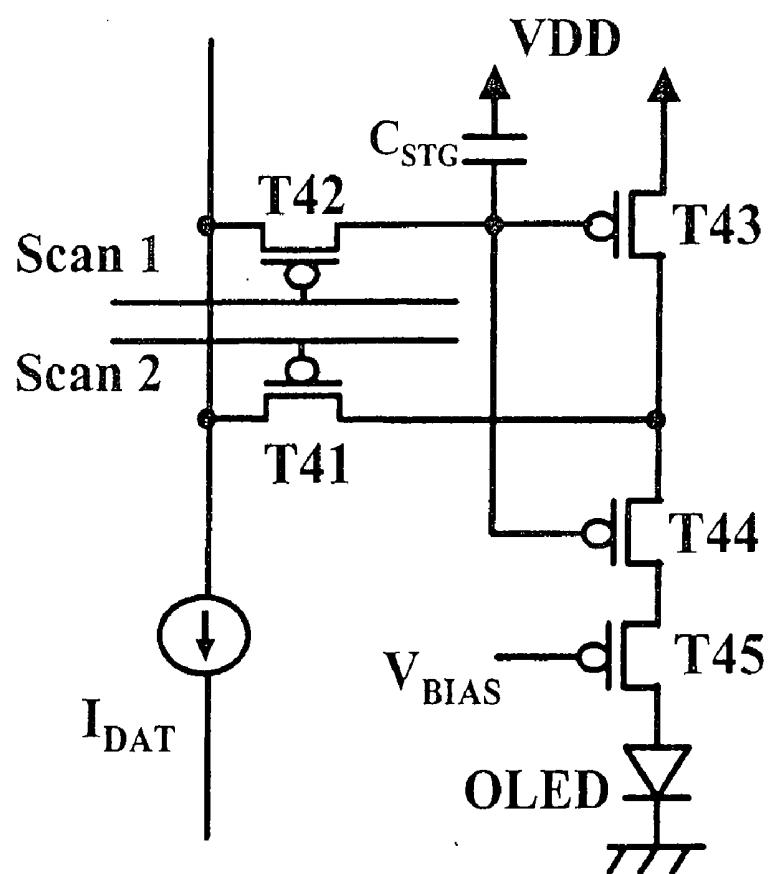


FIG.11

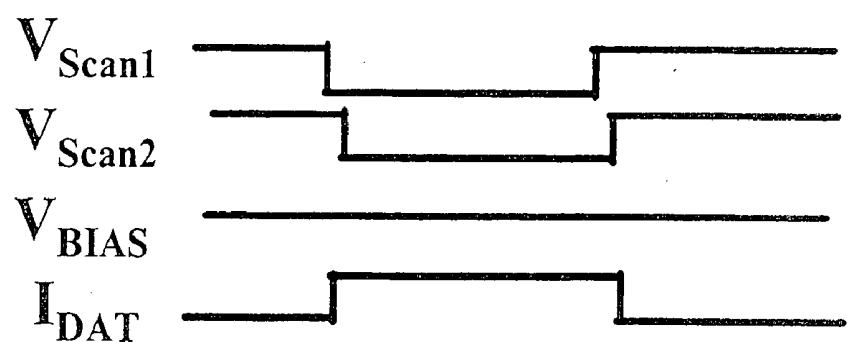


FIG.12

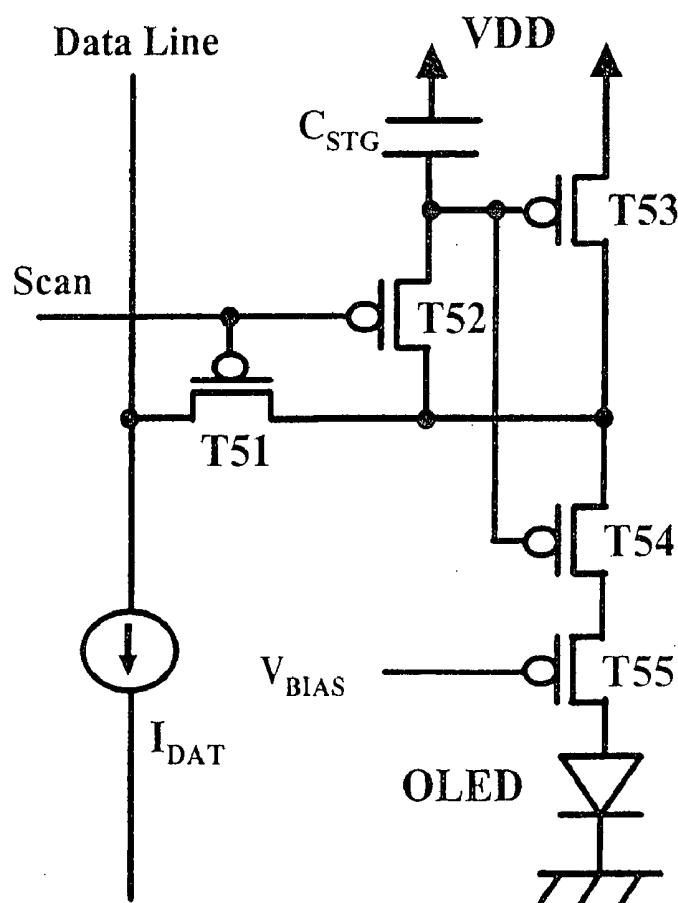


FIG.13

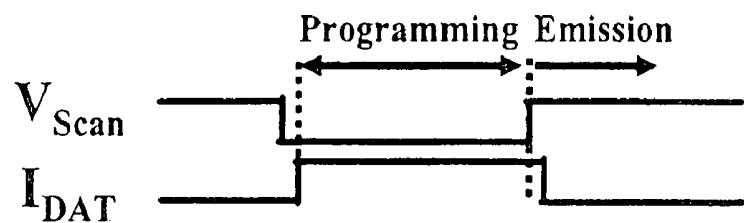


FIG. 14

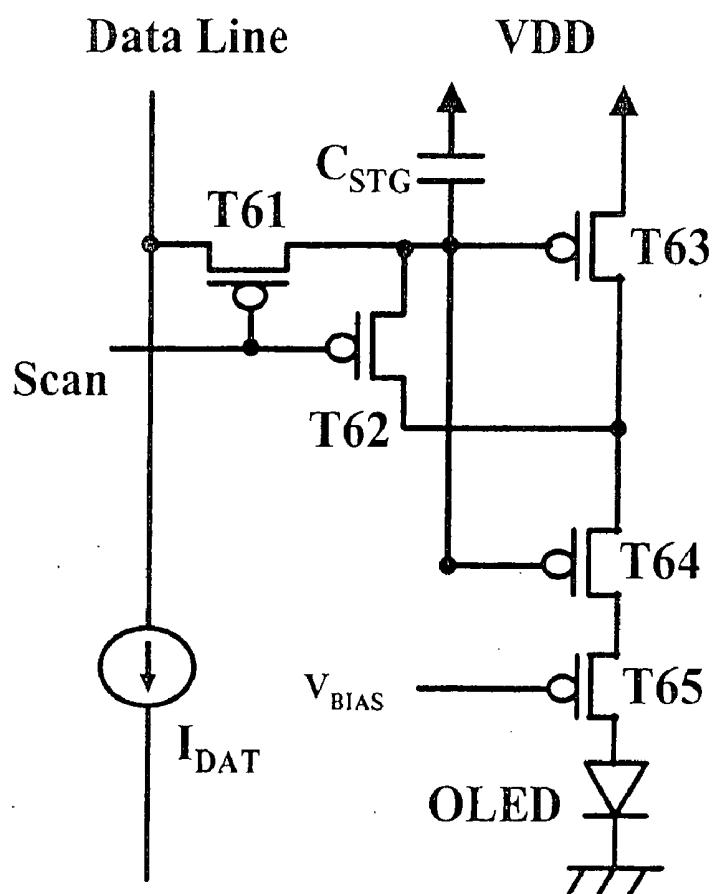


FIG. 15

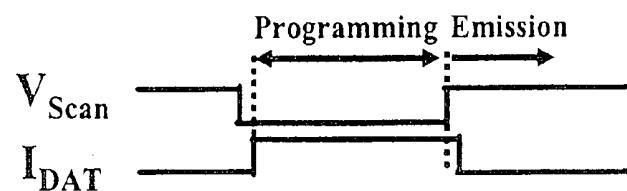


FIG.16

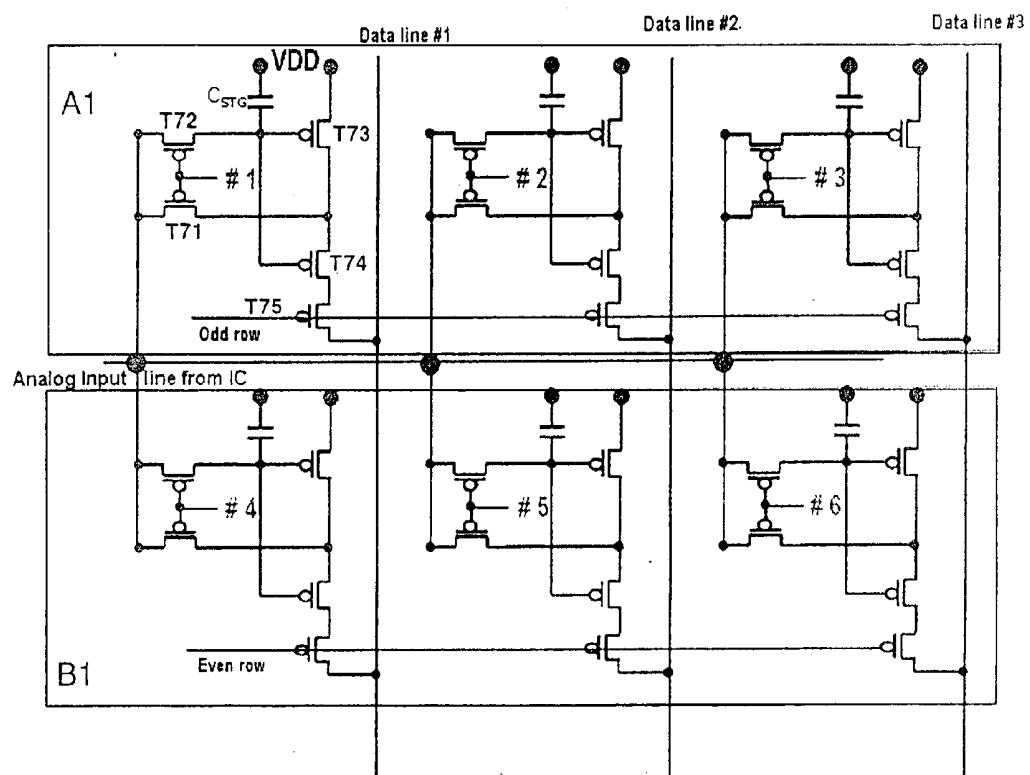


FIG.17

WHEN IT IS OPENED WHEN IT IS OPENED
AN ODD-ROW AN ODD-ROW
DATA LINE DRIVING DATA LINE DRIVING

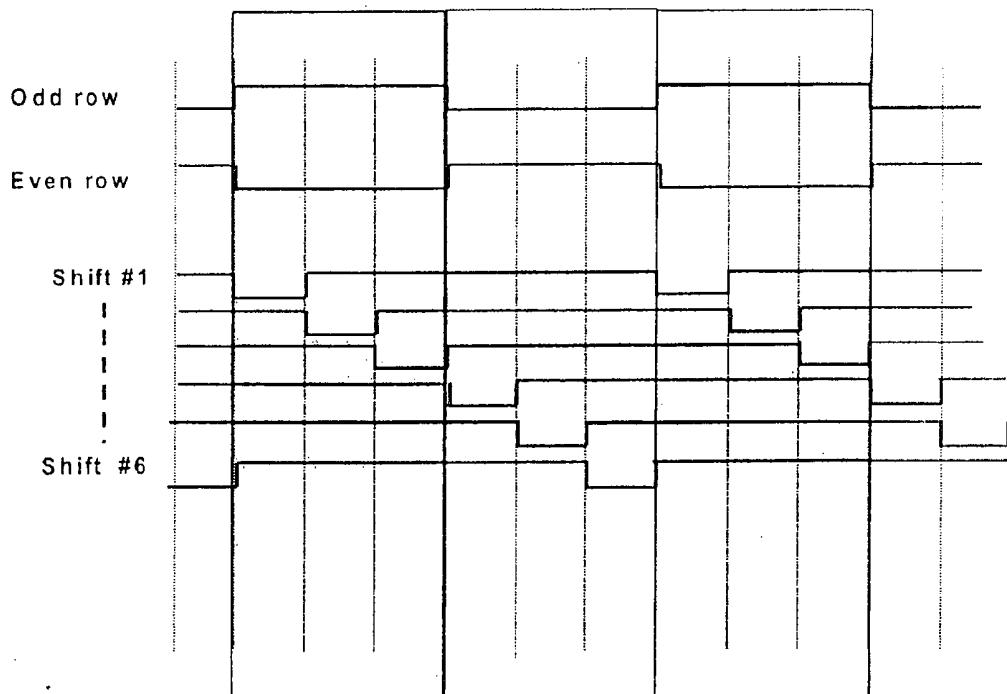


FIG.18

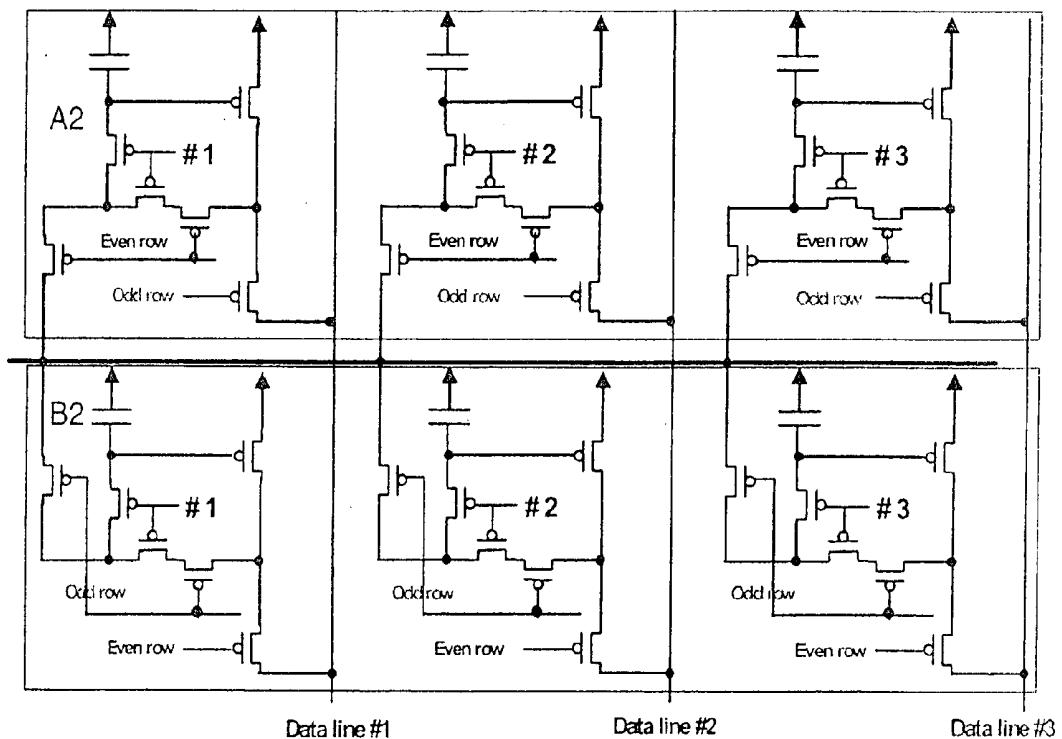


FIG.19

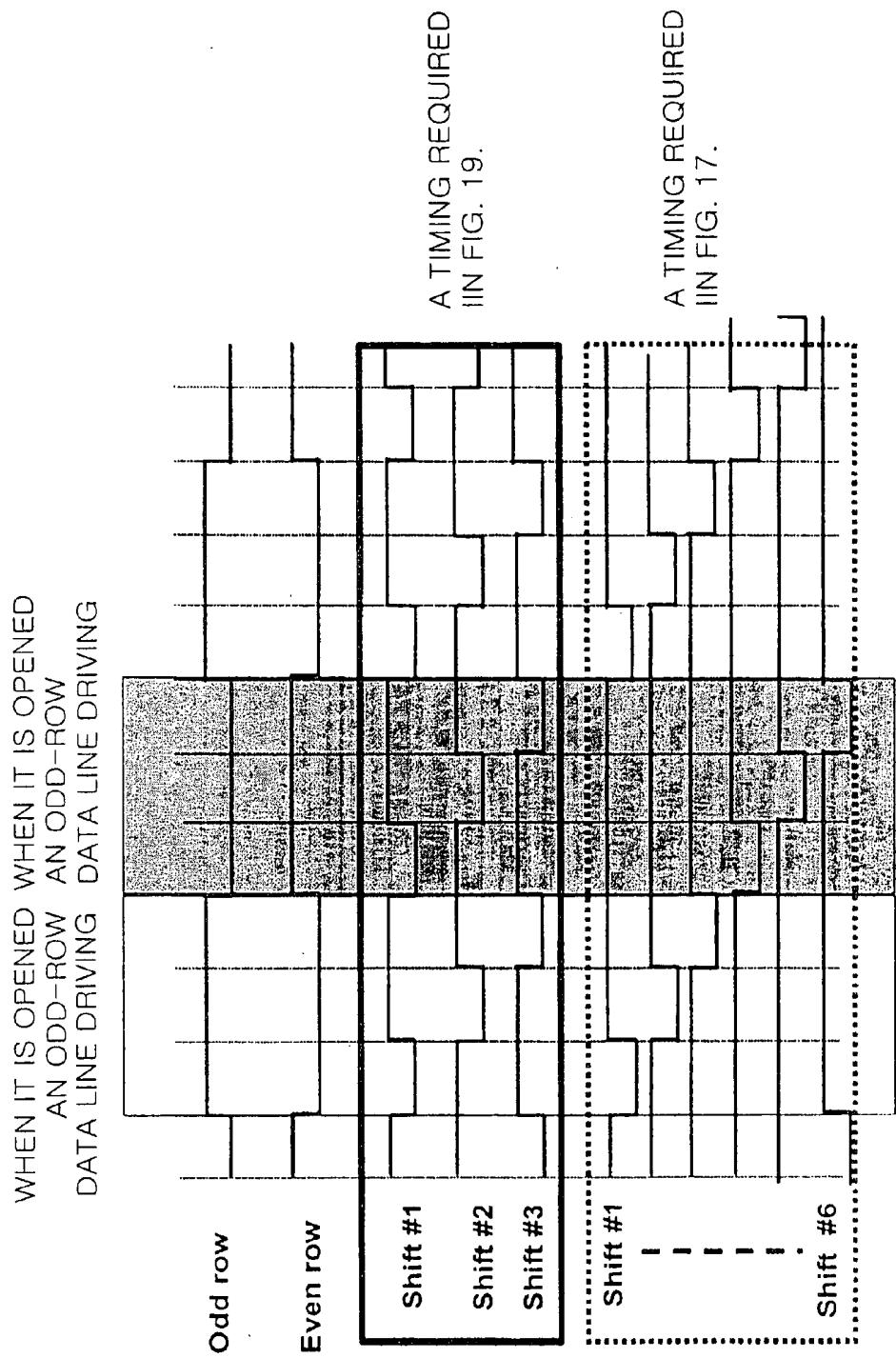


FIG. 20

PICTURE ELEMENT STRUCTURE OF CURRENT PROGRAMMING METHOD TYPE ACTIVE MATRIX ORGANIC EMITTING DIODE DISPLAY AND DRIVING METHOD OF DATA LINE

[0001] The present invention relates generally to the structure of picture elements in an active matrix organic light emitting diode (OLED) display and, in particular, to the structure of current-programming type picture elements suitable for making a self-compensation for current deviation in OLED resulting from the deterioration in a threshold voltage of OLED and non-uniform electric characteristic in thin film transistors.

BACKGROUND ART

[0002] It is so far known from the state of the art that an active matrix liquid crystal display (LCD) using a low temperature polycrystalline silicon thin film transistor (LTPS-TFT) generally provides better driving capability and higher degree of integration than a display adopting amorphous silicon thin film transistors (a-Si TFT) currently in wide use for monitors of notebook computers and desktop personal computers. Thanks to such an advantage, the active matrix LCDs tend to be more frequently adopted for a high resolution LCD device.

[0003] In the meantime, an active matrix OLED device has recently emerged as one of the most competitive next generation of display units, in which the brightness of light emitting elements is subject to the changes in the amount of current flowing through an organic thin film element, so most important in the active matrix OLED is to secure the uniformity in thin film transistors, for example, the uniformity in threshold voltage (V_{th}) and field effect mobility. This is because a uniform current flow in these picture elements can be achieved by compensation of the threshold voltage in TFT. However, it is known from the state of the art that it is very difficult to manufacture an LTPS TFT with such a desired uniformity in threshold voltage and field effect mobility, which is usually processed under a low temperature environment of less than about 450° C. Therefore, various solutions have been so far sought to ensure the uniformity in TFT, with accesses in the side of physical circuits, for instance, among others, by providing a compensation circuit to each picture element in an active matrix OLED panel.

[0004] The basic picture cell scheme in an active matrix OLED may be generally divided into two categories, that is to say, a voltage programming type of inputting picture data with voltage and a current programming type of inputting picture data with current.

[0005] FIG. 1 represents the structure of picture elements widely used in the conventional current programming type of active matrix OLED, and FIG. 2 represents a timing diagram in the picture element of FIG. 1.

[0006] Referring to FIGS. 1 and 2, it is shown that a prior-art current programming type of picture element is configured to have four TFTs T_1 to T_4 and a capacitor C_{stg} , provided that two TFTs T_3 and T_4 of the four TFTs have the substantially identical electrical characteristic. Of this circuit configuration in FIG. 1, TFTs T_1 and T_2 serve as a switch as in an active matrix LCD, the capacitor C_{stg} serves to store a data voltage corresponding to a programmed current, and

TFT T_4 serves to have the current corresponding to the data voltage stored in capacitor C_{stg} flow into the OLED.

[0007] In the basic structure of picture element as shown in FIG. 1, the relationship between the input data current and the output OLED current can be obtained from the following formula:

$$I_{DATA} = \frac{1}{2} \times k3 \times (V_{GS} - V_{DD} - V_{th_T3})^2$$

$$I_{OLED} = \frac{1}{2} \times k4 \times (V_{GS} - V_{DD} - V_{th_T4})^2$$

[0008] wherein k represents a current-voltage relation in a saturation area, that is, $k = \mu \times Cox \times W/L$, in which μ represents a field effect mobility, Cox a capacitance of insulating layer, W a channel width, and L a channel length, respectively.

[0009] Provided that the electrical characteristics of TFTs T_3 and T_4 are the same to each other in each picture element, the current scaling ratio I_{OLED}/I_{DATA} may be equal to $k4/k3$. Therefore, even if a threshold voltage in TFT changes in a current programming type of picture element, it is allowed to output an OLED current only dependent upon the data current irrespectively of the threshold voltage provided that the adjacent two TFTs (for instance, T_3 and T_4) in each picture element have the substantially same electrical characteristics.

[0010] Accordingly, it is appreciated that in case where the OLED threshold voltage deteriorates as a panel operating time becomes longer, the aforementioned prior-art picture cell structure will have a disadvantage that it causes the deviation in OLED output current to occur owing to kink characteristic in TFT T_4 .

SUMMARY OF INVENTION

[0011] It is, therefore, an object of the present invention, with a view to overcome the aforementioned disadvantage, to provide the new structure of picture elements in a current programming type of active matrix organic light emitting diode (OLED) display. The structure makes it possible to compensate for OLED current deviations due to the deterioration in threshold voltage and uneven electrical characteristic in TFT elements between picture elements, thereby allowing the OLED picture elements to provide uniform light emitting characteristic.

[0012] It is another object of the present invention to provide the picture element structure in a current programming type of active matrix OLED display that makes it possible to enlarge a current control width per gray in a current data driver stage for controlling a current source, thanks to lowering the current scaling ratio as compared to the conventional structure of picture element.

[0013] It is still another object of the present invention to provide the picture element structure in a current programming type of active matrix OLED display that is adapted to be less sensitive to the signal delay (RC-delay) phenomenon resulted from a time constant induced by parasitic resistance and capacitance in a data metal line, while inputting more data current to provide an output current in a low level.

[0014] According to one aspect of the present invention, a picture element structure in a current programming type of active matrix OLED display comprises:

[0015] first and second switching transistors for selecting a driving picture element based upon a scan signal applied

from an exterior, said first and second switching transistors being adapted to receive a data current;

[0016] a capacitor for storing electric charges applied from the first and second switching transistors;

[0017] a third driving transistor adapted to be selected by the first and second transistors, for writing the data current thereto and receiving an external power source;

[0018] a fourth driving transistor formed of a current-mirror structure with the third transistor, for receiving a voltage based upon the electric charges stored in the capacitor to supply a current to a corresponding picture element; and

[0019] a fifth transistor connected in series to the fourth driving transistor, for making an output resistance of the fourth driving transistor to increase.

BRIEF DESCRIPTION OF THE DRAWING

[0020] The foregoing and other features and advantages of the invention will be apparent from the following detailed description of a preferred embodiment as illustrated in the accompanying drawings, wherein same reference characters refer to the same parts or components throughout the various views. The drawings are not necessarily to scale, but the emphasis instead is placed upon illustrating the principles of the invention, wherein:

[0021] **FIG. 1** schematically shows a prior art picture element structure in a current programming type of active matrix OLED to compensate for a threshold voltage in TFT;

[0022] **FIG. 2** shows a timing diagram of operation in **FIG. 1**;

[0023] **FIG. 3** schematically shows a picture element structure in a current programming type of active matrix OLED according to a first embodiment of the present invention;

[0024] **FIG. 4** shows a timing diagram of operation in **FIG. 3**;

[0025] **FIG. 5** shows the comparison between the current scaling ratios respectively taken in picture element structures of **FIG. 1** and **FIG. 3**;

[0026] **FIG. 6A** shows the current deviations according to changes in OLED threshold voltage in the picture element structure as shown in **FIG. 3**;

[0027] **FIG. 6B** shows the current deviations according to changes in OLED threshold voltage in the picture element structure as shown in **FIG. 1**;

[0028] **FIG. 7** schematically shows a picture element structure in a current programming type of active matrix OLED according to a second embodiment of the present invention;

[0029] **FIG. 8** shows an operation timing diagram in **FIG. 7**;

[0030] **FIG. 9** schematically shows a picture element structure in a current programming type of active matrix OLED according to a third embodiment of the present invention;

[0031] **FIG. 10** shows a timing diagram of operation in **FIG. 9**;

[0032] **FIG. 11** schematically shows a picture element structure in a current programming type of active matrix OLED according to a fourth embodiment of the present invention;

[0033] **FIG. 12** shows a timing diagram of operation in **FIG. 11**;

[0034] **FIG. 13** schematically shows a picture element structure in a current programming type of active matrix OLED according to a fifth embodiment of the present invention;

[0035] **FIG. 14** shows a timing diagram of operation in **FIG. 13**;

[0036] **FIG. 15** schematically shows a picture element structure in a current programming type of active matrix OLED according to a sixth embodiment of the present invention;

[0037] **FIG. 16** shows a timing diagram of operation in **FIG. 15**;

[0038] **FIG. 17** schematically shows a preferred embodiment of a data driver for driving a picture element in a current programming type of active matrix OLED according to the present invention;

[0039] **FIG. 18** shows a signal timing diagram for operating the data driver shown in **FIG. 17**;

[0040] **FIG. 19** schematically shows another preferred embodiment of a data driver for driving a picture element in a current programming type of active matrix OLED according to the present invention; and

[0041] **FIG. 20** shows a signal timing diagram for operating the data driver shown in **FIG. 19**.

DESCRIPTION OF THE INVENTION

[0042] Hereinafter, a preferred embodiment of the present invention will be described in more detail with reference to the attached drawings. In the following description, for purposes of explanation rather than limitation, specific details are set forth such as the particular architecture, interfaces, techniques, etc., in order to provide a thorough understanding of the present invention. However, it will be apparent to those skilled in the art that the present invention may be practiced in other embodiments, which depart from these specific details. For the purpose of simplicity and clarity, detailed descriptions of well-known devices and methods are omitted so as not to obscure the description of the present invention with unnecessary detail.

[0043] **FIG. 3** schematically shows the structure of picture element in a current programming type of active matrix OLED according to a first embodiment of the present invention, and then **FIG. 4** shows a timing diagram of operation in **FIG. 3**. Referring now to **FIG. 3**, it is seen that the picture element in a current programming type of active matrix OLED according to the preferred embodiment of the present invention is configured to have five P-type thin film transistors (TFTs) T_{11} to T_{15} and a capacitor C_{STG} , in such a manner that a DC signal V_{BIAS} in addition to a scan signal and a data signal I_{DATA} , which are essential signals for the

picture element, is further applied to a gate of TFT T₁₅. It should be appreciated that this embodiment as described above also utilizes a characteristic that threshold voltages and field effect mobility in TFT T₁₃ and TFT T₁₄ are substantially identical to each other, as is with the current-mirror structure indicated in the known structure of **FIG. 1**. In a low temperature polycrystalline silicon thin film transistor (LTPS-TFT) process utilizing eximer laser, those adjacent polycrystalline silicon TFTs simultaneously crystallized with the same laser beam have the substantially identical electrical characteristics to each other, so they are also commonly applied to a current programming type OLED pixel circuit utilizing such a current-mirror configuration.

[0044] Now, the principle of operation according to the preferred embodiment of the present invention will be described in further detail referring to the aforementioned construction. TFTs T₁₁ and T₁₂ are turned ON during a gate selection time, while V_{GS-T14} equals to zero, so TFT T₁₄ turns OFF. Thus, a data current I_{DAT} flows from VDD of TFT T₁₃ operating in a saturation region and then capacitor C_{STG} stores a voltage V_A at a node A determined using the following mathematical formula (1).

$$V_A = VDD - \sqrt{\frac{2I_{DAT}}{k_{13}\mu}} + V_{TH} = VDD - X + V_{TH} \quad (1)$$

[0045] wherein k=Cox W/L (k₁₃=Cox W_{T13}/L_{T13}), and X may be transposed by the following formula:

$$X = \sqrt{\frac{2I_{DAT}}{k_{13}\mu}}$$

[0046] The voltage V_A at node A may be expressed using the below two functions in conjunction with some electrical characteristics such as I_{DAT}, mobility and threshold voltage of a driving TFT in a respective picture element. While TFTs T₁₁ and T₁₂ are keeping an OFF state after a gate selection session, the current I_{OLED} flows through TFT T₁₃ operating in a linear area, represented by the below formula (2), and TFT T₁₄ operating in a saturation area, represented by the formula (3). The reason why these TFTs T₁₃ and T₁₄ are allowed to operate in the linear area and the saturation area is because the gate voltages of TFTs T₁₃ and T₁₄ have the same value V_A.

$$I_{OLED} = I_{DS3} = \frac{\mu k_{13}}{(V_A - VDD - V_{TH})(V_B - VDD)} \cdot \frac{1}{2} (V_B - VDD)^2 \quad (2)$$

$$I_{OLED} = I_{DS4} = \frac{\mu k_{14}}{(V_A - VDD - V_B)^2} = \frac{\mu k_{14}}{V_B - VDD} (X + Y)^2, \text{ let } Y = \frac{V_B - VDD}{V_A - VDD} \quad (3)$$

[0047] Expressing Y as a function of X using the relation of the formula (2)=the formula (3):

$$Y = -X \pm \frac{\sqrt{k_{13}(k_{13} + k_{14})}}{k_{13} + k_{14}} X,$$

[0048] wherein the calculated value of Y is put into the above formulae (2) or (3) in order to express I_{OLED} with respect to I_{DAT}, thereby making the following formula.

$$\begin{aligned} I_{OLED} &= \frac{1}{2} \mu k_{14} \frac{k_{13}(k_{13} + k_{14})}{(k_{13} + k_{14})^2} X^2 \\ &= \frac{1}{2} \mu k_{14} \frac{k_{13}(k_{13} + k_{14})}{(k_{13} + k_{14})^2} \frac{2I_{DAT}}{k_{13}\mu} \end{aligned}$$

Therefore, the current I may be expressed using the following formula:

$$I_{OLED} = \frac{k_{14}}{k_{13} + k_{14}} I_{DAT}$$

[0049] As a result, the OLED current I_{OLED} can be expressed using a linear equation in terms of only the data current I_{DAT}, whereby I_{OLED} in the picture element circuit can be kept independently of non-uniformity of a poly-Si TFT appearing in each picture element.

[0050] Further, it is noted that the circuit implemented according to the present invention operates in a cascade configuration by means of TFT T₁₅. As a threshold voltage in OLED increases, it is meant that in a conventional 4-TFT picture element scheme a drain node voltage in a transistor supplying a current to OLED increases, thereby producing a decreased output current. The reason is because a so-called kink effect is necessarily caused in the output characteristic of low temperature polycrystalline silicon thin film transistor (LTPS-TFT).

[0051] In a 5-TFT picture element configuration according to the present invention, a TFT T₁₅ serves as a resistor always turned ON, so the current drop phenomenon can be suppressed by artificially increasing the output resistance of a driving transistor T₁₄.

[0052] **FIG. 5** is a comparative graph illustrating the current scaling ratios respectively taken in the proposed picture cell scheme according to the first embodiment of the present invention as shown in **FIG. 3** and that of a prior art in **FIG. 1**. According to **FIG. 5**, it is appreciated that the current scaling ratio (51) in the first embodiment of the invention gets lower than the current scaling ratio (52) in the prior art scheme. If the current scaling ratio becomes lower, it would affect an increase in a current control width per 1-gray in a current data driver stage controlling a current source, thereby leading to a considerable advantage upon design of the data drivers. Simultaneously, as it is allowed to input more data current to supply a current at low level, the circuit will become less sensitive to the signal delay phenomenon, i.e. RC delay, owing to a time constant by a capacitance and a parasitic resistance in data metal lines.

[0053] **FIG. 6A** shows the result of simulation utilizing the picture cell scheme according to the first embodiment of the invention as shown in **FIG. 3**, as the threshold voltage in OLED deteriorated. According to the simulation in **FIG. 6a**, the measurement of OLED output current in case where the OLED threshold voltage deteriorates by 1V from 2.7V to 4.7V shows that it is made only 1% of error, which is substantially neglectable. Therefore, it is appreciated that according to the invention the output resistance in TFT T₁₄, due to T₁₅, is forced to increase.

[0054] **FIG. 6B** graphically shows the result of simulation for the OLED output current utilizing the picture cell scheme of a prior art as seen in **FIG. 1**, as the threshold voltage in OLED deteriorated. Here, since a change in the OLED threshold voltage makes a drain node voltage in the drive transistor T_4 change, it is appreciated that it is made at least 10% of error in the OLED output current.

[0055] **FIG. 7** schematically shows the structure of a picture element in a current programming type of active matrix OLED according to a second embodiment of the present invention, and **FIG. 8** shows an operation timing diagram in **FIG. 7**. As seen in **FIG. 7**, the picture element in a current programming type of active matrix OLED according to this embodiment includes four P-type TFTs T_{21} to T_{24} and a N-type TFT T_{25} . Here, it is noted that the compensation for the non-uniformity electrical characteristic in TFTs will be applied in a similar manner as those heretofore described with reference to the first embodiment of the invention.

[0056] It is appreciated however, that the picture cell structure as shown in **FIG. 7** could be used to get rid of such an OLED current error owing to the OLED threshold voltage deterioration, by connecting a gate node of N-type TFT T_{25} with a scan signal without applying an additional signal line V_{bias} used in the aforementioned first embodiment. As a result, it is noted that this embodiment will be more advantageous in use in view of an aperture ratio than the picture cell scheme as shown in the first embodiment.

[0057] **FIG. 9** schematically shows a picture element structure in a current programming type of active matrix OLED according to a third embodiment of the present invention. Referring to **FIG. 9**, the picture element is configured to have only four transistors with TFT T_{15} in the first embodiment removed, in case where no deterioration in OLED elements occurs or the OLED current error is negligibly small.

[0058] Referring to **FIG. 10**, it is shown a timing diagram of operation in **FIG. 9** and it is all the way same as **FIG. 8**. In the embodiment of **FIG. 10**, it is noted that the basic operation thereof will be substantially similar to those described in conjunction with the first embodiment, making a saturation current in TFT T_{34} flow into OLED device to compensate for non-uniformity electrical characteristic in TFTs. As such, the more detailed explanation will be omitted.

[0059] **FIG. 11** schematically shows the picture element structure in a current programming type of active matrix OLED according to a fourth embodiment of the present invention, and

[0060] **FIG. 12** shows a timing diagram of operation in **FIG. 11**. As seen in **FIG. 11**, the picture element in a current programming type of active matrix OLED according to this embodiment includes five P-type TFTs T_{41} to T_{45} and a capacitor C_{STG} , as seen in the first embodiment of **FIG. 3**. Here, the difference in structure between this embodiment and the first embodiment of **FIG. 3** is that two scan signals are applied to effect more stable circuit operation, so that TFT T_{41} is turned OFF earlier than TFT T_{42} in operation. This inventive idea of controlling a switching of two TFTs T_{41} and T_{42} using these two scan signals may be likewise applied to all the aforementioned embodiments of the

present invention and any other alternative embodiments to be discussed in the following.

[0061] **FIG. 13** schematically shows the picture element structure in a current programming type of active matrix OLED according to a fifth embodiment of the present invention, and **FIG. 14** shows a timing diagram of operation in **FIG. 13**. According to **FIG. 13**, it is noted that the structure of this fifth embodiment is different from that of the first embodiment in that the position of TFT T_{52} is rearranged in such a manner that the data current I_{DATA} is only applied to a source of TFT T_5 , and a drain of TFT T_{52} is connected to a drain of TFT T_{53} . As seen in the timing diagram of **FIG. 14**, its basic operation of writing the data current into TFT T_{53} upon a programming operation and then making the saturation current in TFT T_{54} flow into OLED device, the saturation current being compensated for the change in threshold voltages of TFT and OLED, will be substantially same as those discussed in the first embodiment of the invention. Accordingly, more detailed explanation will be omitted for the purpose of simplicity in explanation.

[0062] **FIG. 15** schematically shows the picture element structure in a current programming type of active matrix OLED according to a sixth embodiment of the present invention, and **FIG. 16** shows a timing diagram of operation in **FIG. 15**. In the picture cell scheme shown in **FIG. 13**, it should be noted that the structure of this sixth embodiment is only different from that of the first embodiment of **FIG. 3** in that the position of TFT T_{62} is arranged such that the data current I_{DATA} is only applied to a source of TFT T_{61} from a gate of T_{63} and a drain of TFT T_{62} is connected to a drain of TFT T_{63} . Here, as seen in the timing diagram of **FIG. 16**, its basic operation of writing the data current into TFT T_{63} upon a programming operation and then making the saturation current in TFT T_{64} flow into OLED device, the saturation current being compensated for the change in threshold voltages of TFT and OLED will be substantially similar to those mentioned in the first embodiment. As such, more detailed explanation will be omitted for the purpose of simplicity in explanation.

[0063] The basic concept that was applied to the preferred embodiments of **FIGS. 13 and 15**, for outputting the compensated OLED current by changing the physical position of TFT T_2 , may be also utilized for the third embodiment of **FIG. 9** according to the present invention.

[0064] Therefore, the expert skilled in the art will well appreciate that, among the various picture element circuits configured based upon the above-described embodiments of the present invention, the picture element circuit with five TFTs may be configured with four P-type TFTs and a N-type TFT as shown in the second embodiment, so as to remove V_{bias} line, thereby allowing to increase the aperture ratio of a display panel.

[0065] Further, the picture element configuration according to the present invention may be configured using N-type TFT as a drive transistor, in a similar way as aforementioned.

[0066] **FIG. 17** schematically shows a preferred embodiment of a current data driver for driving a picture element in a current programming type of active matrix OLED according to the present invention, in which the data driver is

adapted to compensate for the non-uniformity electrical characteristic of TFTs in drivers. **FIG. 18** shows a signal timing diagram associated with operation of the current data driver as shown in **FIG. 17**.

[0067] Referring now to **FIGS. 17 and 18**, explanation is made to a circuit operation to drive three data lines in the panel using a single external current input signal generated from an external integrated circuit.

[0068] If it is assumed that a TFT to drive picture cells in a panel is of N-type, a data current driver in the panel needs to be fabricated of a current-source type, so that the data current driver has to be fabricated of P-type. As seen in **FIG. 17**, two P-type current memory cells are connected in parallel for each data line in the panel. The operation will be described hereunder.

[0069] When an even-row signal of **FIG. 18** goes low, current memory cells in a section B1 are allowed to simultaneously drive data lines in the panel thanks to the even-row signal while current memory cells in a section A1 are sequentially storing the currents externally supplied (e.g., shift register signals #1 to #3). Then, when it is opened an odd-row in the panel, the current memory cells in section A1 operate to simultaneously drive data lines in the panel owing to the odd-row signal, while the current memory cells in section B1 keep to store in sequence the currents externally supplied (e.g., shift register signals #4 to #6). Here, a signal input from a shift register integrated within the panel may be used for the signal of current stored in sequence. Accordingly, assuming that a single external current line is adapted to drive M data lines, it will be appreciated by an expert in the art that 2M-stage shift registers is required. Of course, assuming that it is to be driven by M-stage of shift registers, each shift register will be added by a logic gate as necessary. Further, it should be noted that because the circuit operates to provide the data line in the panel with a current reduced by a given scaling ratio with respect to the input data current, it can diminish occurrence of the signal delay problem, i.e., RC-delay, owing to a time constant in the data line.

[0070] **FIG. 19** schematically shows another preferred embodiment of a data driver for driving a picture element in a current programming type of active matrix organic light emitting diode (OLED) according to the present invention, wherein the data driver is adapted to compensate for the non-uniformity electrical characteristic of TFTs in the driver. Further, **FIG. 20** shows a signal timing diagram associated with operating the data driver shown in **FIG. 19**.

[0071] In **FIGS. 19 and 20**, if it is assumed that a TFT to drive picture cells in a panel is of N-type, the proposed data current driver in the panel has six P-type TFTs and a capacitor. The operation will be described hereunder.

[0072] When it is opened an even-row in the panel (i.e., even-row signal), the current memory cells in section B2 operate to simultaneously drive data lines in the panel owing to the even-row signal, while the proposed current memory cells in section A2 are storing in sequence the currents externally supplied (e.g., shift register signals #1 to #3). At this time, it should be noted that although the current memory cells in the section B2 also receive the signals #1 to #3, the current externally supplied with the odd-row signal does not influence any current memory cells in the section B2, and the data driver is designed so that owing to the

odd-row signal, gate electric charges memorized in its preceding stage are kept. In a similar way, when it is opened an odd-row in the panel (i.e., of odd-row signal), the current memory cells in section A2 operate to simultaneously drive data lines in the panel owing to the odd-row signal, while the proposed current memory cells in section B2 are storing in sequence the currents externally supplied (e.g., shift register signals #1 to #3). Here, it should be noted that although the current memory cells in the section A2 also receive the signals #1 to #3, the current externally supplied with the even-row signal does not influence any current memory cells in the section B2, and the data driver circuit is designed so that no influence is made by the even-row signal to the gate electric charges memorized in its preceding stage.

[0073] According to the present invention, it is noted that for the purpose of driving the current data driver circuit of **FIG. 17**, there are usually required two times as many stages of shift registers as the number of data lines to be driven by a single external current source.

[0074] Furthermore, it should be also noted that when utilizing the data line driver circuit of **FIG. 19**, there will be only required as many stages of shift registers as the number of data lines to be driven by a single external current source.

[0075] As understood from the foregoing description, the novel structure of picture elements in a current programming type of active matrix organic light emitting diode (OLED) display according to the present invention makes it possible to effectively compensate for OLED current deviations due to the deterioration in OLED as well as the non-uniformity electrical characteristic in TFT elements between picture elements. Accordingly, this structure allows for the active matrix OLED picture elements to have very uniform light emitting characteristic.

[0076] Furthermore, it will be appreciated by an expert in the art that the first embodiment of the invention has a considerable degree of advantage in a manufacturing process in that all TFTs are fabricated of p-type transistor, wherein V_{BIAS} signal is further applied in addition to the essential signals, i.e., a scan signal and an I_{DATA} signal, while the second embodiment has an advantage in that an additional signal line can be removed to extend a light emitting area in a picture cell, thereby effecting the substantially same operating characteristic only using those essential signals without applying the V_{BIAS} signal. Consequently, it is appreciated that the picture cell configuration according to the present invention provides an excellent operating characteristic capable of outputting the same OLED current for the same data input in spite of some degree of changes in threshold voltages in TFTs and OLEDs. As a result, it will become possible to implement more competitive display devices as compared to those with a conventional picture cell configuration.

[0077] In the mean time, it is noted in the state of the art that most of the known current programming type picture cell schemes are generally configured so that a data current applied upon selection of a picture cell flows into OLED with a scaling downed current in a current-mirror or with the same current value as the data current after the selection of a picture cell. Therefore, considering the material characteristic of OLED which needs to represent high quality of gray scale within a range of 1 μ A to 2 μ A at the maximum, it will require a data current driver capable of controlling in

scale of a few tens of nA. In contrast, the picture cell structure in a current programming type of active matrix OLED display according to the present invention makes it possible to drive the OLED with an increased data current controlled by the better scaling-down ratio in comparison to a current scaling-down ratio in a current-mirror, so it has an advantage in that design of such a current driver becomes easier than that of a prior art, and a data line charging time is reduced.

[0078] While the preferred embodiments of the present invention have been illustrated and described, it will be understood by those skilled in the art that various changes and modifications may be made, and equivalents may be substituted for elements thereof without departing from the true scope of the present invention. Therefore, it is intended that the present invention not be limited to the particular embodiment disclosed as the best mode contemplated for carrying out the present invention; instead, it is intended that the present invention include all embodiments falling within the scope of the appended claims.

What is claimed is:

1. A picture element structure in a current programming type of active matrix organic light emitting diode (OLED), comprising:

first and second switching transistors for selecting a driving picture element based upon a scan signal applied from an exterior, said first and second switching transistors being adapted to receive a data current; a capacitor for storing electric charges applied from the first and second switching transistors;

a third driving transistor adapted to be selected by the first and second transistors, for writing the data current thereto and receiving an external power source;

a fourth driving transistor formed of a current-mirror structure with the third transistor, for receiving a voltage based upon the electric charges stored in the capacitor to supply a current to a corresponding picture element; and

a fifth transistor connected in series to the fourth driving transistor, for making an output resistance of the fourth driving transistor to increase.

2. The picture element structure in a current programming type of active matrix organic light emitting diode (OLED) according to claim 1, wherein the magnitude of the current applied to the corresponding picture element is operatively controllable depending upon a ratio of channel width/channel length (W/L) in the third driving transistor and channel width/channel length (W/L) in the fourth driving transistor.

3. The picture element structure in a current programming type of active matrix organic light emitting diode (OLED) according to claim 1, wherein said first to fifth transistors are formed of the same conductivity type of transistors.

4. The picture element structure in a current programming type of active matrix organic light emitting diode (OLED) according to claim 1, wherein said fifth transistor is formed of a conductivity type of transistors different from that of said first to fourth transistors, and for improvement in the aperture ratio of a display device, said fifth switching transistor is coupled with the scan signal, thereby eliminating the external power source.

5. A picture element structure in a current programming type of active matrix organic light emitting diode (OLED) having at least one scan line, at least one data line and a power supply source, comprising:

a capacitor connected to the power supply source, for storing electric charges supplied to said data line;

a first switching element having a P-type thin film transistor, of which gate is connected to the scan line and source/drain current path is connected to the data line;

a second switching element having a P-type thin film transistor, of which gate is connected to the scan line and source/drain current path is formed between said capacitor and said first switching element;

a third driving element having a P-type thin film transistor, of which gate is connected to the capacitor and source/drain current path is formed in said power supply source;

a driving element having a P-type thin film transistor, of which gate is connected to the gate of the third driving element and source/drain current path is connected in said a third driving element; and

an organic light emitting diode (OLED) for emitting light by a current flowing through said driving element.

6. A method for driving a data line in a current programming type of active matrix organic light emitting diode (OLED) panel, characterized in that an externally applied current is scaled down by a predetermined ratio to have a reduced current flow into the data line.

7. A method for driving a data line in a current programming type of active matrix organic light emitting diode (OLED) panel, characterized in that for memorizing an externally applied current, a plurality of signal lines supplied to current memory cells connected in parallel are driven in an overlapped configuration with each other.

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专利名称(译)	电流编程方法型有源矩阵有机发光二极管显示器的像素结构及数据线的驱动方法		
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申请(专利权)人(译)	首尔国立大学的产业基础		
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摘要(译)

本发明提供了一种新颖的电流编程型半导体器件中的像素结构，特别是有源矩阵有机发光二极管(OLED)显示器的像素结构。由于阈值电压的劣化和薄膜晶体管中的不均匀电特性，该装置对OLED电流偏差进行自补偿。本发明还提供了一种用于驱动数据驱动器的方法，该数据驱动器能够补偿用于驱动当前编程型有源矩阵OLED显示装置中的像素的驱动器中的薄膜晶体管的不均匀电特性。

